PROCEEDINGS OF SPIE

Hyperspectral Imaging Sensors: Innovative Applications and Sensor Standards 2016

David P. Bannon Editor

20 April 2016 Baltimore, Maryland, United States

Sponsored and Published by SPIE

Volume 9860

Proceedings of SPIE 0277-786X, V. 9860

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Hyperspectral Imaging Sensors: Innovative Applications and Sensor Standards 2016, edited by David P. Bannon, Proc. of SPIE Vol. 9860, 986001 · © 2016 SPIE · CCC code: 0277-786X/16/\$18 · doi: 10.1117/12.2244350

Proc. of SPIE Vol. 9860 986001-1

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Author(s), "Title of Paper," in Hyperspectral Imaging Sensors: Innovative Applications and Sensor Standards 2016, edited by David P. Bannon, Proceedings of SPIE Vol. 9860 (SPIE, Bellingham, WA, 2016) Six-digit Article CID Number.

ISSN: 0277-786X ISSN: 1996-756X (electronic) ISBN: 9781510601017

Published by **SPIE** P.O. Box 10, Bellingham, Washington 98227-0010 USA Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445 SPIE.org

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Printed in the United States of America.

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